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INCORMATION DISCLOSURE	Application Number	10/752,092	
METORMATION DISCLOSURE SEATEMENT BY APPLICANT	Filing Date	01/07/2004	
Day Submitted: August 18, 2004	First Named Inventor	Masatomo SHIBATA	
	Group Art Unit	2841 2013	
as many sheets as necessary)	Examiner Name	Unassigned / um	
Sheet 1 of 1	Attorney Docket Number	035532-0138	
Sheet 1 of 1	Attorney Docket Number	035532-0138	

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Examiner Signature Date Considered 7/21/05		
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	INFORMATIC	N DISCLO	SURE	Applicati n Number	-Unassigned - 18/7521192	
STATEMENT BY APPLICANT			CANT	Filing Date	01/07/2004	
Date Submitted: January 7, 2004				First Named Invent r	Masatomo SHIBATA	
	Date Submitte	u. January	7, 2004	Group Art Unit	Unassigned 28/3	
	(use as many si	heets as ne	cessary)	Examiner Name	Unassigned Blum	
Sheet	1	of	1	Attorney Docket Number	035532-0138	

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